

### Is Now Part of



# ON Semiconductor®

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June 2015

### FPF2C8P2NL07A

### F2, 3-phase, 3-level NPC module with Press-fit / NTC

### **General Description**

Fairchild's new inverter modules provide low conduction and switching loss as well. And Press-Fit technology provides simple and reliable mounting. These modules are optimized for the applications such as solar inverter and UPS where a high efficiency and robust design is needed.

#### **Electrical Features**

- · High Efficiency
- · Low Conduction and Switching Losses
- · Field Stop IGBT for Inner and Outer Switch
- STEALTH<sup>TM</sup> Diode for Path Diode
- · Built-in NTC for Temperature Monitoring

#### **Mechanical Features**

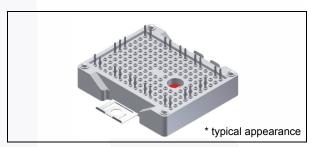
- · Compact Size: F2 Package
- · Press-fit Contact Technology
- Al<sub>2</sub>O<sub>3</sub> Substrate with Low Thermal Resistance

### **Applications**

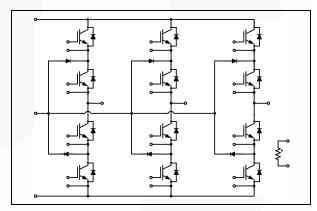
- Solar Inverter
- UPS

#### **Related Materials**

 AN-4167: Mounting Guideline for F1 / F2 Modules with Press-Fit Pins



Package Code: F2



**Internal Circuit Diagram** 

### **Package Marking and Ordering Information**

Device	Device Marking	Package	Packing Type	Quantity / Tray
FPF2C8P2NL07A	FPF2C8P2NL07A	F2	Tray	14

## Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Descr	Rating		
Outer IGBT	(Q1, Q4, Q5, Q8, Q9, Q12)	·		
V <sub>CES</sub>	Collector-Emitter Voltage		650	V
V <sub>GES</sub>	Gate-Emitter Voltage		± 20	V
I <sub>C</sub>	Continuous Collector Current	@ T <sub>C</sub> = 80 °C, T <sub>Jmax</sub> = 175 °C	30	Α
I <sub>CM</sub>	Pulsed Collector Current	limited by T <sub>Jmax</sub>	60	Α
$P_{D}$	Maximum Power Dissipation	@ T <sub>C</sub> = 25 °C	135	W
T <sub>J</sub>	Operating Junction Temperature		- 40 to + 150	°C
Inner IGBT(	Q2, Q3, Q6, Q7, Q10, Q11)			-
V <sub>CES</sub>	Collector-Emitter Voltage		650	V
V <sub>GES</sub>	Gate-Emitter Voltage		± 20	V
I <sub>C</sub>	Continuous Collector Current	@ T <sub>C</sub> = 80 °C, T <sub>Jmax</sub> = 175 °C	50	Α
I <sub>CM</sub>	Pulsed Collector Current	limited by T <sub>Jmax</sub>	100	Α
$P_{D}$	Maximum Power Dissipation	@ T <sub>C</sub> = 25 °C	174	W
T <sub>J</sub>	Operating Junction Temperature		- 40 to + 150	°C
Outer - Inne	er IGBT Series Connection			
SCWT	Short Circuit Withstand Time	$V_{DC}$ = 300 V, $V_{GE}$ = 15 V $T_{C}$ = 25 °C	4	μS
Diode				·
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage		650	V
l <sub>F</sub>	Continuous Forward Current	@ T <sub>C</sub> = 80 °C, T <sub>Jmax</sub> = 175 °C	15	Α
I <sub>FM</sub>	Maximum Forward Current		30	Α
$P_{D}$	Maximum Power Dissipation	@ T <sub>C</sub> = 25 °C	100	W
T <sub>J</sub>	Operating Junction Temperature		- 40 to + 150	°C
Module				
T <sub>STG</sub>	Storage Temperature		- 40 to + 125	°C
V <sub>ISO</sub>	Isolation Voltage	@ AC 1 min.	2500	V
IsoMaterial	Internal Isolation Material		Al <sub>2</sub> O <sub>3</sub>	
T <sub>MOUNT</sub>	Mounting Torque		2.0 to 5.0	Nm
Creepage	Terminal to Heat Sink		11.5	mm
	Terminal to Terminal		6.3	mm
Clearance	Terminal to Heat Sink		10.0	mm
	Terminal to Terminal		5.0	mm

## **Electrical Characteristics** $T_C = 25$ °C unless otherwise noted.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
Outer IGE	ВТ				<u> </u>	
Off Charac	cteristics					
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 1 mA	650	-	-	V
I <sub>CES</sub>	Collector Cut-off Current	$V_{CE} = V_{CES}$ , $V_{GE} = 0$ V	-	-	250	μΑ
I <sub>GES</sub>	Gate-Emitter Leakage Current	V <sub>GE</sub> = V <sub>GES</sub> , V <sub>CE</sub> = 0 V	-	-	2	μА
On Charac	eteristics	92 920 02				
V <sub>GE(th)</sub>	Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 30 \text{ mA}$	4.5	5.6	6.7	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	I <sub>C</sub> = 30 A, V <sub>GE</sub> = 15 V	-	1.55	2.2	V
CE(Sat)		I <sub>C</sub> = 30 A, V <sub>GE</sub> = 15 V @T <sub>C</sub> = 125 °C	-	1.75	-	V
		I <sub>C</sub> = 60 A, V <sub>GF</sub> = 15 V	-	2.13	-	V
Switching	Characteristics	0 02				
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>CC</sub> = 300 V	-	33	-	ns
t <sub>r</sub>	Rise Time	I <sub>C</sub> = 30 A	-	43	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GE</sub> = ± 15 V	-	197	-	ns
t <sub>f</sub>	Fall Time	$R_G = 20 \Omega$ Inductive Load	-	17	-	ns
E <sub>ON</sub>	Turn-On Switching Loss per Pulse	T <sub>C</sub> = 25 °C	-	0.68	-	mJ
E <sub>OFF</sub>	Turn-Off Switching Loss per Pulse		-	0.38	-	mJ
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>CC</sub> = 300 V	-	29	-	ns
t <sub>r</sub>	Rise Time	I <sub>C</sub> = 30 A	_	50	_	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GE} = \pm 15 \text{ V}$	_	205	_	ns
t <sub>f</sub>	Fall Time	$R_G = 20 \Omega$ Inductive Load	_	25	_	ns
E <sub>ON</sub>	Turn-On Switching Loss per Pulse	T <sub>C</sub> = 125 °C	_	0.86	_	mJ
E <sub>OFF</sub>	Turn-Off Switching Loss per Pulse		_	0.52	_	mJ
Q <sub>g</sub>	Total Gate Charge	$V_{CC} = 300 \text{ V}, I_{C} = 30 \text{ A}, V_{GE} = \pm 15 \text{ V}$	_	0.26	_	μС
$R_{\theta JC}$	Thermal Resistance of Junction to Case	per Chip	_	0.20	1.11	°C/V
Inner IGB	RT					
Off Charac						
		\\\ -0\\  1 -1 mA	650	_		V
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage  Collector Cut-off Current	$V_{GE} = 0 \text{ V, } I_{C} = 1 \text{ mA}$		-	250	
I <sub>CES</sub>		$V_{CE} = V_{CES}, V_{GE} = 0 V$	-	-	250	μΑ
I <sub>GES</sub> On Charac	Gate-Emitter Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0 V$	-	_	2	μА
		\\ -\\   -50 mA	4.5	F.6	6.7	V
V <sub>GE(th)</sub>	Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_{C} = 50 \text{ mA}$	4.5	5.6	6.7	•
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	I <sub>C</sub> = 50 A, V <sub>GE</sub> = 15 V	-	1.65	2.3	V
		I <sub>C</sub> = 50 A, V <sub>GE</sub> = 15 V @T <sub>C</sub> = 125 °C	-	1.95	-	-
Consider Indian an	Chama ata miatina	I <sub>C</sub> = 100 A, V <sub>GE</sub> = 15 V	-	2.49	-	V
	Characteristics Turn-On Delay Time	V <sub>CC</sub> = 300 V		44		
t <sub>d(on)</sub>	· ·	$I_{\rm C} = 50  \rm A$	-	41	-	ns
t <sub>r</sub>	Rise Time	V <sub>GE</sub> = ± 15 V	-	65	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_G = 15 \Omega$	-	233	-	ns
t <sub>f</sub>	Fall Time	Inductive Load	-	18	-	ns
E <sub>ON</sub>	Turn-On Switching Loss per Pulse	$T_C = 25 ^{\circ}C$	-	0.87	-	mJ
E <sub>OFF</sub>	Turn-Off Switching Loss per Pulse	V = 200 V	-	0.77	-	mJ
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>CC</sub> = 300 V I <sub>C</sub> = 50 A	-	39	-	ns
t <sub>r</sub>	Rise Time	$V_{GE} = \pm 15 \text{ V}$	-	76	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_G = 15 \Omega$	-	243	-	ns
t <sub>f</sub>	Fall Time	Inductive Load	-	20	-	ns
E <sub>ON</sub>	Turn-On Switching Loss per Pulse	T <sub>C</sub> = 125 °C		0.99	-	mJ
E <sub>OFF</sub>	Turn-Off Switching Loss per Pulse		-	0.93	-	mJ
Qg	Total Gate Charge	$V_{CC}$ = 300 V, $I_{C}$ = 50 A, $V_{GE}$ = ± 15 V	-	0.39	_	nC
$R_{\theta JC}$	Thermal Resistance of Junction to Case	per Chip	-	-	0.86	°C/V

### **Electrical Characteristics** $T_C = 25$ °C unless otherwise noted.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
Diode			'		•	
V <sub>FM</sub>	Diode Forward Voltage	I <sub>F</sub> = 15 A	-	2.55	3.4	V
		I <sub>F</sub> = 15 A @T <sub>C</sub> = 125 °C	-	1.78	-	V
I <sub>R</sub>	Reverse Leakage Current	V <sub>R</sub> = 650 V	-	-	250	μА
t <sub>rr</sub>	Reverse Recovery Time	V <sub>R</sub> = 300 V, I <sub>F</sub> = 15 A	-	23	-	ns
I <sub>rr</sub>	Reverse Recovery Current	$di_F / dt = 700 \text{ A/us}$	-	9.9	-	Α
Q <sub>rr</sub>	Reverse Recovery Charge	$T_C = 25 ^{\circ}C$	-	113	-	nC
t <sub>rr</sub>	Reverse Recovery Time	V <sub>R</sub> = 300 V, I <sub>F</sub> = 15 A	-	49	-	ns
I <sub>rr</sub>	Reverse Recovery Current	$di_F / dt = 700 \text{ A/us}$	-	15.2	-	Α
Q <sub>rr</sub>	Reverse Recovery Charge	$T_{\rm C}$ = 125 °C	-	366	-	nC
$R_{\theta JC}$	Thermal Resistance of Junction to Case	per Chip	-	-	1.44	°C/W
NTC_ The	ermistor					
R <sub>NTC</sub>	Rated Resistance	T <sub>C</sub> = 25 °C	-	5.0	-	kΩ
		T <sub>C</sub> = 100 °C	-	493	-	Ω
	Tolerance	T <sub>C</sub> = 25 °C	- 5	-	+ 5	%
$P_{D}$	Power Dissipation	T <sub>C</sub> = 25 °C	-	-	20	mW
B <sub>Value</sub>	B-Constant	B <sub>25/50</sub>	-	3375	-	K
		B <sub>25/100</sub>	-	3436	-	K

### **Typical Performance Characteristic**

Fig 1. Typical Output Characteristics

- Outer IGBT

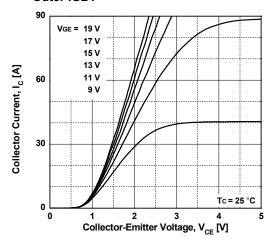


Fig 2. Typical Output Characteristics

- Outer IGBT

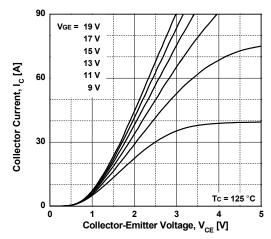


Fig 3. Typical Saturation Voltage Characteristics

- Outer IGBT

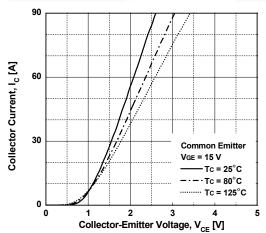


Fig 4. Switching Loss vs. Collector Current

- Outer IGBT

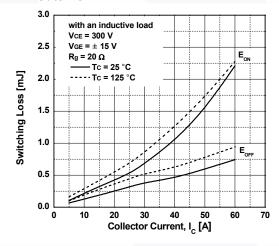


Fig 5. Switching Loss vs. Gate Resistance

- Outer IGBT

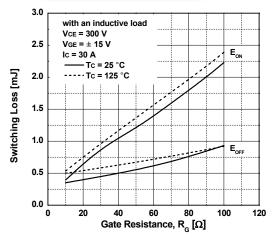
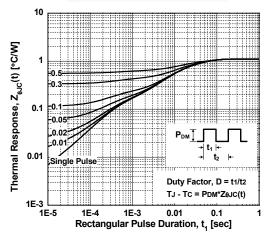


Fig 6. Transient Thermal Impedance

- Outer IGBT



### **Typical Performance Characteristic**

Fig 7. Typical Output Characteristics

- Inner IGBT

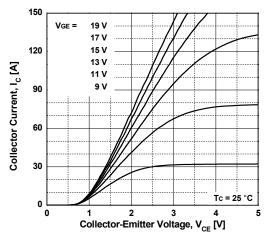


Fig 8. Typical Output Characteristics

- Inner IGBT

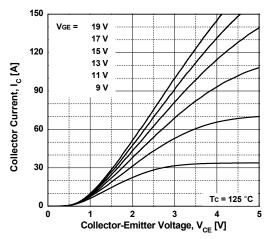


Fig 9. Typical Saturation Voltage Characteristics

- Inner IGBT

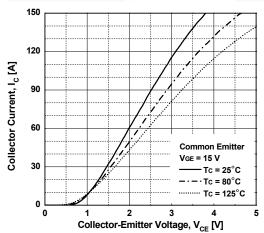


Fig 10. Switching Loss vs. Collector Current

- Inner IGBT

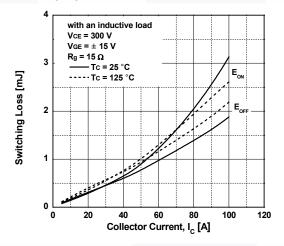


Fig 11. Switching Loss vs. Gate Resistance
- Inner IGBT

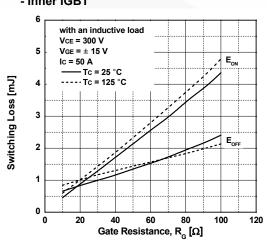
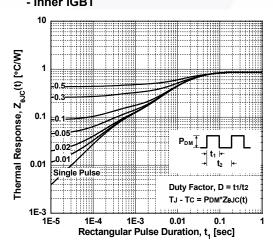


Fig 12. Transient Thermal Impedance
- Inner IGBT



### **Typical Performance Characteristic**

Fig 13. Reverse Bias Safe Operating Area (RBSOA)

- Outer IGBT

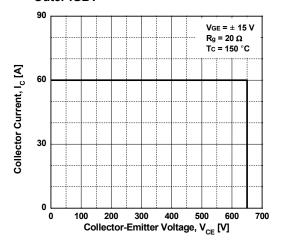


Fig 14. Reverse Bias Safe Operating Area (RBSOA)

- Inner IGBT

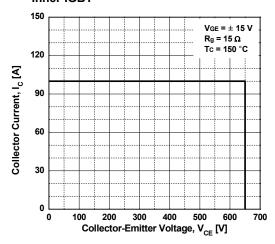


Fig 15. Typical Forward Voltage Drop

- Diode

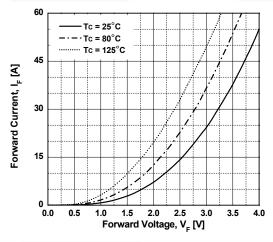


Fig 16. Reverse Recovery Energy vs. Forward Current

- Diode

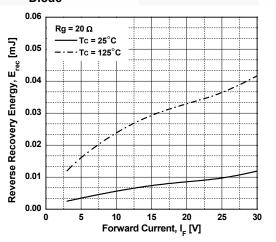
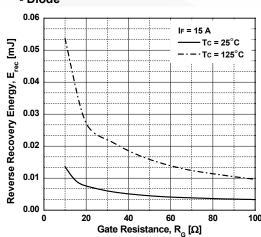
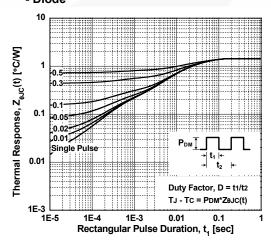


Fig 17. Reverse Recovery Energy vs. Gate Resistance Fig 18. Transient Thermal Impedance

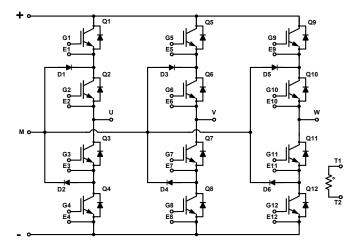
- Diode



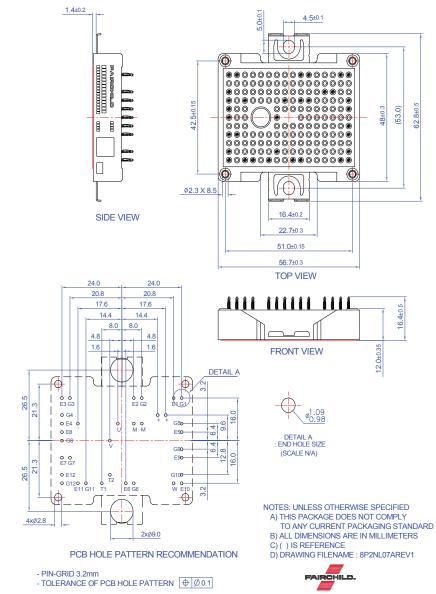
- Diode



### **Internal Circuit Diagram**



### Package Outlines [mm]







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#### PRODUCT STATUS DEFINITIONS

#### Definition of Terms

Datasheet Identification	Product Status	Definition	
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.	
		Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.	
		Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.	
Obsolete Not In Production		Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.	

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